











CSD18504Q5A

SLPS366E -JUNE 2012-REVISED SEPTEMBER 2014

# CSD18504Q5A 40-V N-Channel NexFET™ Power MOSFET

#### **Features**

- Ultra-Low Qa and Qad
- Low Thermal Resistance
- Avalanche Rated
- Logic Level
- Pb Free Terminal Plating
- **RoHS Compliant**
- Halogen Free
- SON 5 mm x 6 mm Plastic Package

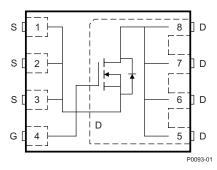
## **Applications**

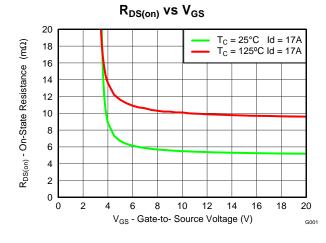
- DC-DC Conversion
- Secondary Side Synchronous Rectifier
- **Battery Motor Control**

#### 3 Description

This 5.3 m $\Omega$ , SON 5 × 6 mm, 40 V NexFET<sup>TM</sup> power MOSFET is designed to minimize losses in power conversion applications.







#### **Product Summary**

$T_A = 25^\circ$	С	TYPICAL VA	UNIT	
$V_{DS}$	Drain-to-Source Voltage 40			
$Q_g$	Gate Charge Total (4.5 V)	7.7	nC	
$Q_{gd}$	Gate Charge Gate-to-Drain	2.4	nC	
D	Drain-to-Source On-Resistance	V <sub>GS</sub> = 4.5 V	7.5	mΩ
R <sub>DS(on)</sub>	Diam-to-Source On-Resistance	V <sub>GS</sub> = 10 V	5.3	mΩ
$V_{GS(th)}$	Threshold Voltage	1.9	V	

## Ordering Information<sup>(1)</sup>

Device	Qty	Media	Package	Ship
CSD18504Q5A	2500	13-Inch Reel	SON 5 mm × 6 mm	Tape and
CSD18504Q5AT	250	7-Inch Reel	Plastic Package	Reel

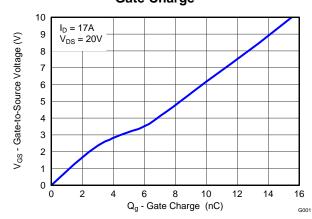
For all available packages, see the orderable addendum at the end of the data sheet.

#### **Absolute Maximum Ratings**

Aboolato Maximam Hatingo							
T <sub>A</sub> = 2	5°C	VALUE	UNIT				
$V_{DS}$	Drain-to-Source Voltage	40	V				
$V_{GS}$	Gate-to-Source Voltage	±20	V				
	Continuous Drain Current (Package limited)	50					
I <sub>D</sub>	Continuous Drain Current (Silicon limited), T <sub>C</sub> = 25°C	75	Α				
	Continuous Drain Current <sup>(1)</sup>	15					
I <sub>DM</sub>	Pulsed Drain Current <sup>(2)</sup>	275	Α				
Б	Power Dissipation <sup>(1)</sup>	3.1	W				
P <sub>D</sub>	Power Dissipation, T <sub>C</sub> = 25°C	77	VV				
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range	-55 to 150	°C				
E <sub>AS</sub>	Avalanche Energy, single pulse I <sub>D</sub> = 43 A, L = 0.1 mH, R <sub>G</sub> = 25 $\Omega$	92	mJ				

- (1) Typical  $R_{\theta JA}=40^{\circ} C/W$  on a 1-inch² , 2-oz. Cu pad on a 0.06-inch thick FR4 PCB.
- (2) Max  $R_{\theta JC}$  = 2.0 °C/W, pulse duration ≤100 µs, duty cycle ≤1%

## **Gate Charge**





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4 Revision History	
Changes from Revision D (August 2014) to Revision E	Page
<ul> <li>Increased pulsed current to 275 A</li> <li>Updated the SOA in Figure 10</li> </ul>	
Changes from Revision C (May 2013) to Revision D	Page
<ul> <li>Added 7-inch reel to Ordering Information table</li> <li>Added parameter for power dissipation with case temperature held to 25°C</li> <li>Updated pulsed current conditions</li> <li>Updated Figure 1 to a normalized R<sub>BJC</sub> curve</li> </ul>	
Changes from Revision B (November 2012) to Revision C	Page
Updated this drawing table to include E3, e1, and e2 dimensions      Added Stencil Pattern	
Changes from Revision A (October 2012) to Revision B	Page
<ul> <li>Changed the R<sub>DS(on)</sub> vs V<sub>GS</sub> and Gate Charger graphs</li> <li>Changed R<sub>θJA</sub> Max value From: 51 To: 50°C/W</li> <li>Changed the Typical MOSFET Characteristics section</li> </ul>	3
Changes from Original (June 2012) to Revision A	Page
<ul> <li>Changed the Transconductance TYP value From: 63 S To: 71 S</li> <li>Changed the Turn On and Turn Off Delay Time, Rise and Fall Time Test Conditions I<sub>DS</sub> = 17 A, R<sub>G</sub> = 0 Ω</li> </ul>	From: I <sub>DS</sub> = 17 A, R <sub>G</sub> = 2 Ω To:
<ul> <li>Changed the Q<sub>rr</sub> Reverse Recovery Charge TYP value From: 18 nC To: 39 nC</li> </ul>	3

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# 5 Specifications

#### 5.1 Electrical Characteristics

 $(T_{\Delta} = 25^{\circ}C \text{ unless otherwise stated})$ 

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS		·			
BV <sub>DSS</sub>	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40			V
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 32 V			1	μΑ
I <sub>GSS</sub>	Gate-to-Source Leakage Current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V			100	nA
V <sub>GS(th)</sub>	Gate-to-Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.5	1.9	2.4	V
В	Drain-to-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 17 \text{ A}$		7.5	9.8	mΩ
R <sub>DS(on)</sub>	Drain-to-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 17 \text{ A}$		5.3	6.6	mΩ
g <sub>fs</sub>	Transconductance	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 17 A		71		S
DYNAMI	C CHARACTERISTICS		·			
C <sub>iss</sub>	Input Capacitance			1380	1656	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 20 \text{ V}, f = 1 \text{ MHz}$		310	372	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			8	9.6	pF
$R_G$	Series Gate Resistance			1.4	2.8	Ω
$Q_g$	Gate Charge Total (4.5 V)			7.7	9.2	nC
Qg	Gate Charge Total (10 V)			16	19	
Q <sub>gd</sub>	Gate Charge Gate-to-Drain	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 17 A		2.4		nC
$Q_{gs}$	Gate Charge Gate-to-Source			3.2		nC
Q <sub>g(th)</sub>	Gate Charge at V <sub>th</sub>			2.2		nC
Q <sub>oss</sub>	Output Charge	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V		21		nC
t <sub>d(on)</sub>	Turn On Delay Time			3.2		ns
t <sub>r</sub>	Rise Time	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 10 V,		6.8		ns
t <sub>d(off)</sub>	Turn Off Delay Time	$I_{DS} = 17 \text{ A}, R_G = 0 \Omega$		12		ns
$t_f$	Fall Time			2		ns
DIODE C	CHARACTERISTICS				<del></del>	
$V_{SD}$	Diode Forward Voltage	I <sub>SD</sub> = 17 A, V <sub>GS</sub> = 0 V		0.8	1	V
Q <sub>rr</sub>	Reverse Recovery Charge	V <sub>DS</sub> = 20 V, I <sub>F</sub> = 17 A,		39		nC
t <sub>rr</sub>	Reverse Recovery Time	di/dt = 300 A/µs		28		ns

#### 5.2 Thermal Information

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

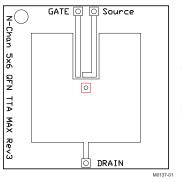
	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-Case Thermal Resistance <sup>(1)</sup>			2.0	°C/W
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance <sup>(1)(2)</sup>			50	C/VV

<sup>(1)</sup> R<sub>θJC</sub> is determined with the device mounted on a 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inches x 1.5-inches (3.81-cm x 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. R<sub>θJC</sub> is specified by design, whereas R<sub>θJA</sub> is determined by the user's board design.

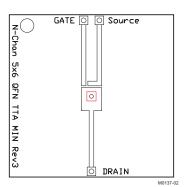
(2) Device mounted on FR4 material with 1-inch2 (6.45-cm2), 2-oz. (0.071-mm thick) Cu.

Product Folder Links: CSD18504Q5A





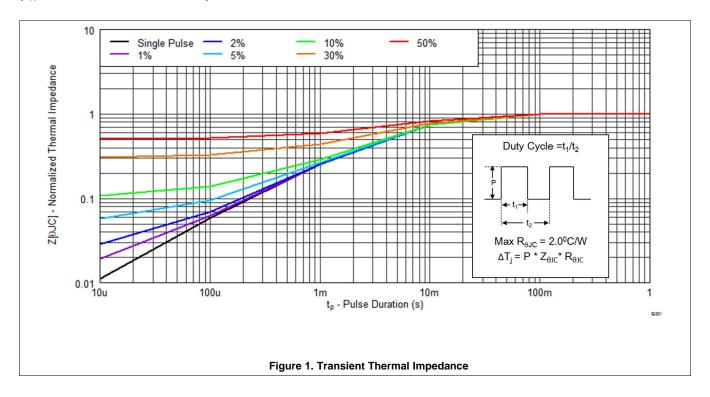
Max  $R_{\theta JA} = 50^{\circ} C/W$  when mounted on 1 inch² (6.45 cm²) of 2-oz. (0.071-mm thick) Cu.



Max  $R_{\theta JA} = 125^{\circ} C/W$  when mounted on a minimum pad area of 2-oz. (0.071-mm thick) Cu.

## 5.3 Typical MOSFET Characteristics

(T<sub>A</sub> = 25°C unless otherwise stated)

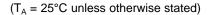


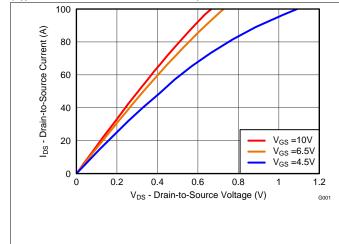
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## **Typical MOSFET Characteristics (continued)**





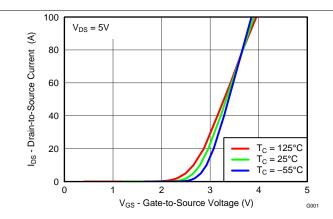
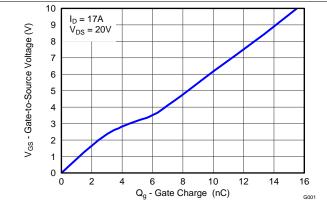
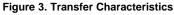


Figure 2. Saturation Characteristics





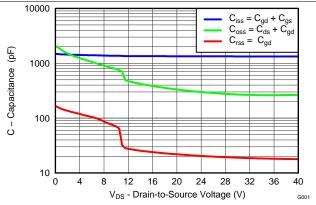


Figure 4. Gate Charge

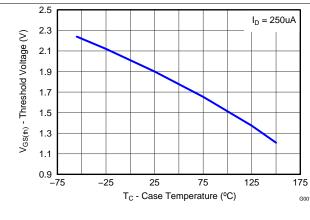


Figure 5. Capacitance

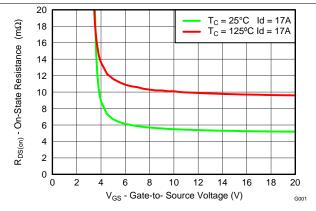


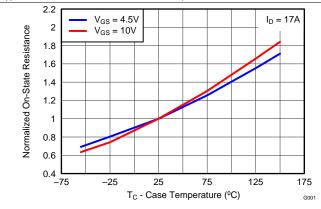
Figure 6. Threshold Voltage vs Temperature

Figure 7. On-State Resistance vs Gate-to-Source Voltage



## **Typical MOSFET Characteristics (continued)**

(T<sub>A</sub> = 25°C unless otherwise stated)



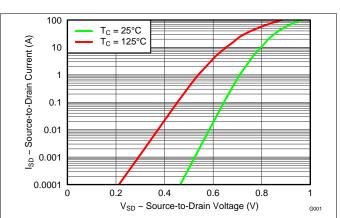


Figure 8. Normalized On-State Resistance vs Temperature



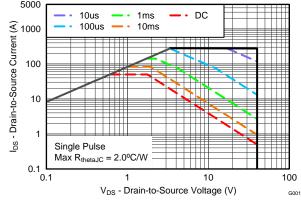


Figure 9. Typical Diode Forward Voltage

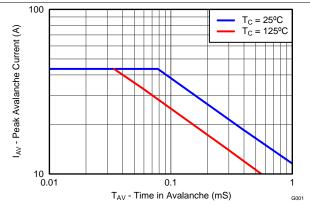


Figure 10. Maximum Safe Operating Area

Figure 11. Single Pulse Unclamped Inductive Switching

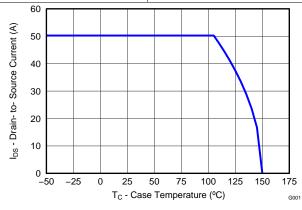


Figure 12. Maximum Drain Current vs Temperature



# 6 Device and Documentation Support

#### 6.1 Trademarks

NexFET is a trademark of Texas Instruments.

#### 6.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 6.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

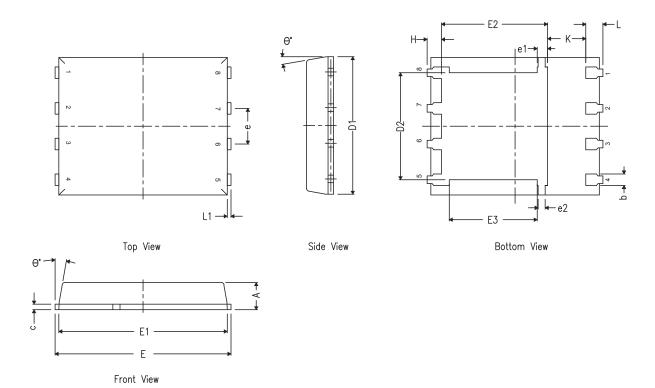
Product Folder Links: CSD18504Q5A



# 7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

#### 7.1 Q5A Package Dimensions

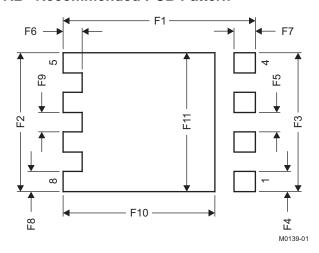


DIM	MILLIMETERS							
DIM	MIN	NOM	MAX					
Α	0.90	1.00	1.10					
b	0.33	0.41	0.51					
С	0.20	0.25	0.34					
D1	4.80	4.90	5.00					
D2	3.61	3.81	4.02					
E	5.90	6.00	6.10					
E1	5.70	5.75	5.80					
E2	3.38	3.58	3.78					
E3	3.03	3.13	3.23					
е	1.17	1.27	1.37					
e1	0.27	0.37	0.47					
e2	0.15	0.25	0.35					
Н	0.41	0.56	0.71					
K	1.10							
L	0.51	0.61	0.71					
L1	0.06	0.13	0.20					
θ	0°		12°					

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# 7.2 Recommended PCB Pattern



	MILLIM	IETERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
F1	6.205	6.305	0.244	0.248	
F2	4.46	4.56	0.176	0.18	
F3	4.46	4.56	0.176	0.18	
F4	0.65	0.7	0.026	0.028	
F5	0.62	0.67	0.024	0.026	
F6	0.63	0.68	0.025	0.027	
F7	0.7	0.8	0.028	0.031	
F8	0.65	0.7	0.026	0.028	
F9	0.62	0.67	0.024	0.026	
F10	4.9	5	0.193	0.197	
F11	4.46	4.56	0.176	0.18	

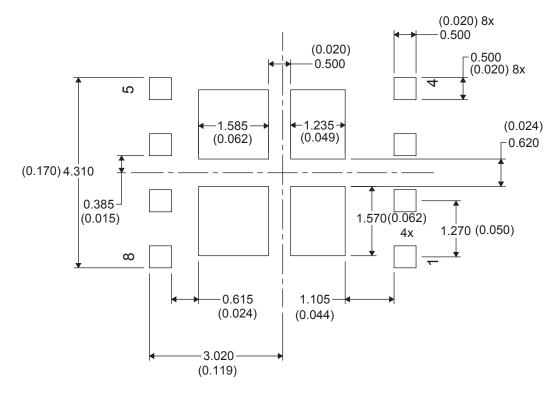
For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.

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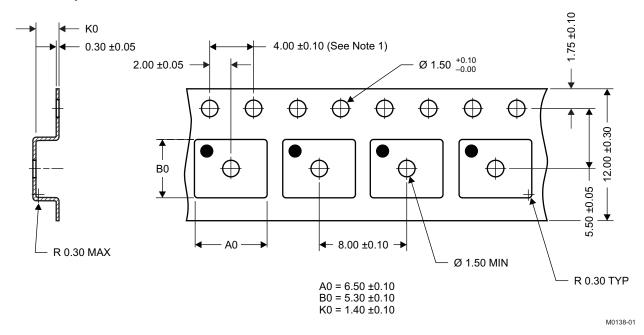
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#### 7.3 Recommended Stencil Opening



#### 7.4 Q5A Tape and Reel Information



#### Notes:

- 1. 10-sprocket hole-pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm
- 3. Material: black static-dissipative polystyrene
- 4. All dimensions are in mm (unless otherwise specified).
- 5. A0 and B0 measured on a plane 0.3 mm above the bottom of the pocket.

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## PACKAGE OPTION ADDENDUM

5-Sep-2014

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CSD18504Q5A	ACTIVE	VSONP	DQJ	8	2500	Pb-Free (RoHS Exempt)	CU SN	Level-1-260C-UNLIM	-55 to 150	CSD18504	Samples
CSD18504Q5AT	ACTIVE	VSONP	DQJ	8	250	Pb-Free (RoHS Exempt)	CU SN	Level-1-260C-UNLIM	-55 to 150	CSD18504	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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# **PACKAGE OPTION ADDENDUM**

5-Sep-2014

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#### Products Applications

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